

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination INOUE ET AL.	
		10/664,671	Examiner	Art Unit Shean C. Wu
			1756	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 05-112778	05-1993	Japan	---	---
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	English abstract for JP 05-112778.
	V	CAPLUS 1994: 285205
	W	CAPLUS 1967: 489834
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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